1. Record Nr.   UNISA996279557403316

   Titolo   ANSI/IEEE Std C57.12.91-1979 : IEEE Standard Test Code for Dry-Type Distribution and Power Transformers / / Institute of Electrical and Electronics Engineers

   Pubbl/distr/stampa   New York, New York : , : IEEE, , 1979

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   Disciplina   621.381

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                         Electric transformers - Standards

   Lingua di pubblicazione   Inglese

   Formato   Materiale a stampa

   Livello bibliografico Monografia

   Sommario/riassunto   Methods for performing tests specified in IEEE Std C57.12.01-1989 and other referenced standards applicable to dry-type distribution and power transformers are described. This standard is intended for use as a basis for performance, safety, and the proper testing of dry-type distribution and power transformers. This standard applies to all dry-type transformers except instrument transformers, step-voltage and induction voltage regulators, arc furnace transformers, rectifier transformers, specialty transformers, and mine transformers.

2. Record Nr.	UNINA9910983481503321
Autore	Wallraven Christian
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Altri autori (Persone)	LiuCheng-Lin RossArun
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Sommario/riassunto	This volume constitutes the refereed proceedings of the 4th International Conference on Pattern Recognition and Artificial Intelligence, ICPRAI 2024, held in Jeju Island, South Korea, during July 03-06, 2024. The 69 full papers presented together with 08 short papers were carefully reviewed and selected from a total of 135 submissions. The conference focuses on topics that includes advanced deep learning approaches for image and document processing, generative AI, novel analysis methods for medical data, and biometrics. .